

Substitute for form 1449/PTO INFORMATION DISCLOSURE STATEMENT BY APPLICANT <i>(Use as many sheets as necessary)</i>			Complete If Known		
			Application Number	10/676,680-Conf. #8216	
			Filing Date	October 1, 2003	
			First Named Inventor	Gail A. Alverson	
			Art Unit	2195	
			Examiner Name	E. C. Wai	
Sheet	1	of	1	Attorney Docket Number	324758001US4

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code ² (if known)			
/EW/		US-6,219,690	04-17-2001	Slingwine et al.	
/EW/		US-6,529,958	03-04-2003	Oba et al.	
/EW/		US-5,778,230	07-07-1998	Wimble et al.	
/EW/		US-6,223,202	04-24-2001	Bayeh	
/EW/		US-5,740,413	04-14-1998	Alpert et al.	
/EW/		US-5,257,358	10-26-1993	Cohen	
/EW/		US-5,197,138	03-23-1993	Hobbs et al.	
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Examiner Initials*	Cite No. ¹	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages Or Relevant Figures Appear	T ³
		Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)				

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/EW/		US-6,282,638	08-28-2001	Dowling	
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/EW/		US-6,470,376	10-22-2002	Tanaka et al.	

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/EW/		Silberschatz et al., "Operating System Concepts," Fifth Edition, John Wiley & Sons, Inc., 1998, page 103.	

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				Art Unit	2195
				Examiner Name	LILIAN VO
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/EW/		US-6,487,590-B1	11-26-2002	Foley et al.	
/EW/		US-6,594,698-B1	07-15-2003	Chow et al.	
/EW/		US-6,622,155-B1	09-16-2003	Haddon et al.	
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/EW/		US-5,179,702	01-12-1993	Spix et al.	
/EW/		US-5,485,626-B1	01-16-1996	Lawlor et al.	
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/EW/		US-5,668,993	09-16-1997	Peters et al.	
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/EW/		US-6,272,520-B1	08-07-2001	Sharangpani et al.	
/EW/		US-6,298,370-B1	10-02-2001	Tang et al.	
/EW/		US-6,505,229-B1	01-07-2003	Turner et al.	
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				Filing Date	Herewith
				First Named Inventor	Gall A. Alverson
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/EW/		5,594,864		Trauben	1/14/97	
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/EW/		5,652,889		Sites	7/29/97	
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/EW/		5,768,592		Chang	6/16/98	
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/EW/		6,002,872		Alexander III et al.	12/14/99	
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/EW/		6,009,269		Burrows et al.	12/28/99	
/EW/		6,029,005		Radigan	2/22/00	
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/EW/		6,101,524		Choi et al.	8/8/00	
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/EW/		DE	DE19710252		Fujitsu Ltd.	2/26/98		
/EW/		DE	DE19710252		Fujitsu Ltd. (English Abstract)	2/26/98		
/EW/		EP	EP0422945		International Business Machines	4/17/91		
/EW/		EP	EP0455966		International Business Machines	11/13/91		
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/EW/		EP	EP0855648		Texas Instruments, Inc.	7/29/98		
/EW/		EP	EP0864979		Digital Equipment Corporation	9/16/98		
/EW/		UK	GB2307760		AT&T Corp.	6/4/97		

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				Group Art Unit	
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